# MSKSEMI 美森科













**ESD** 

MOV

GDT

PLED

# 2N7002BK-MS

**Product specification** 





#### **Features**

- 60V,0.3A, RDS(ON) =2.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

# **Application**

- Motor Drive
- Power Tools
- LED Lighting

BVDSS	RDSON	ID
60V	2.2Ω	0.3A

## **Reference News**

PACKAGE OUTLINE	Pin Configuration	Marking
G S SOT-23	Go	LNW *

# **Absolute Maximum Ratings** (TA=25 ℃ unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain- Source Voltage	60	V
Vgs	Gate- Source Voltage	±20	V
I <sub>D</sub>	Drain Current – Continuous (Tc=25℃)	0.3	Α
טו	Drain Current – Continuous (Tc=100℃)	0.1	Α
Ірм	Drain Current – Pulsed <sup>1</sup>	0.8	Α
PD	Power Dissipation (T <sub>C</sub> =25 ℃)	0.35	W
	Power Dissipation – Derate above 25℃	0.003	<b>W/</b> ℃
Тѕтс	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 150	°C



#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	∘c/W

# **Electrical Characteristics**(TJ=25 °C , unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain- Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			<b>V</b>
lana	Drain-Source Leakage Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	ųΑ
IDSS	Brain- Gourge Leanage Garrent	V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =125℃			10	uА
Igss	Gate- Source Leakage Current	V <sub>GS-</sub> ±20V , V <sub>DS</sub> =0V			±10	uА

#### On Characteristics

D	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =0.3A		2.2	2.8	Ω
RDS(ON)	Static Diam-Source On-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =0.2A		2 4	3 0	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1	1.6	2.5	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =0.3A		0.5		S

## **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2</sup> , <sup>3</sup>		-	3.7	5.6	
Qgs	Gate-Source Charge <sup>2, 3</sup>	V <sub>DS</sub> =30V , V <sub>GS</sub> =10V , I <sub>D</sub> =1A		0.9	1.4	nC
Qgd	Gate-Drain Charge <sup>2 , 3</sup>			0.4	0.6	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2, 3</sup>			3	6	
Tr	Rise Time <sup>2 , 3</sup>	V <sub>DD</sub> =30V ,V <sub>GS</sub> =10V , R <sub>G</sub> =6		5	10	ne
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>2, 3</sup>	Ω I <sub>D</sub> =0.2A		14	27	ns
Tf	Fall Time <sup>2, 3</sup>			9	17	
Ciss	Input Capacitance			25.5	38	
Coss	Output Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , F=1MHz		17	26	pF
Crss	Reverse Transfer Capacitance			7.8	12	•

## **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V . Force Current			0.3	Α
<b>I</b> SM	Pulsed Source Current	VG-VD-0V, I orde Gurrent			1.2	Α
Vsp	Diode Forward Voltage	V <sub>G</sub> s=0V , I <sub>S</sub> =1A , T <sub>J</sub> =25℃			1	V
trr	Reverse Recovery Time	V <sub>GS</sub> =50V, I <sub>S</sub> =1A,		3.4		ns
Qrr	Reverse Recovery Charge	dI/dt=100A/µs TJ=25℃		0.7		nC

#### Note:

- ${\it 1.} Repetitive \ Rating: \ Pulsed \ width \ limited \ by \ maximum \ junction \ temperature.$
- $2\,.$  The data tested by pulsed , pulse width  $\leqq \,300\,\text{us}$  , duty cycle  $\leqq \,2\,\%\,.$
- $\ \ 3.\,Essentially\,\,independent\,\,of\,\,operating\,\,temperature.$

#### **ELECTRICAL CHARACTERISTICS CURVE**

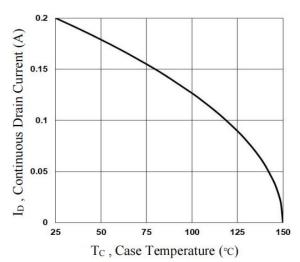


Fig.1 Continuous Drain Current vs. Tc

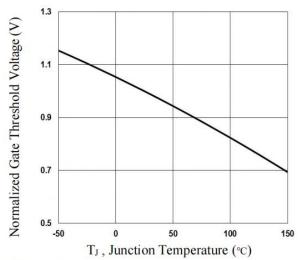


Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

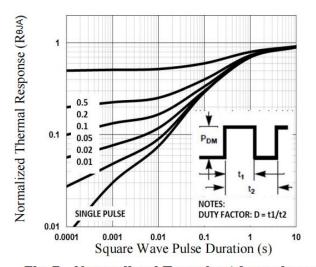


Fig.5 Normalized Transient Impedance

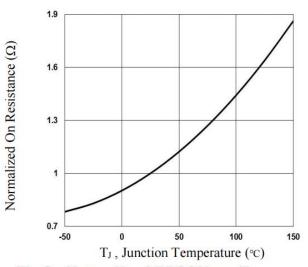


Fig.2 Normalized RDSON vs. TJ

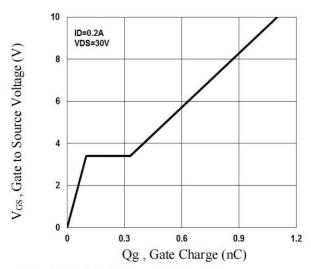


Fig.4 Gate Charge Waveform

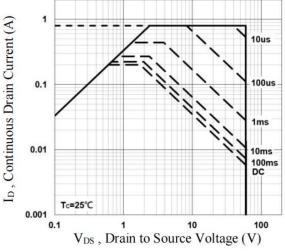
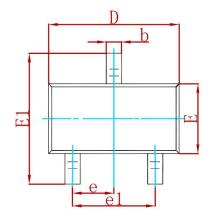
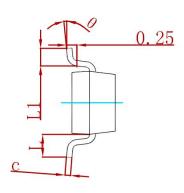


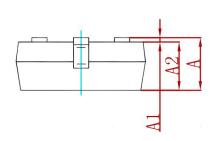
Fig.6 Maximum Safe Operation Area



## PACKAGE MECHANICAL DATA

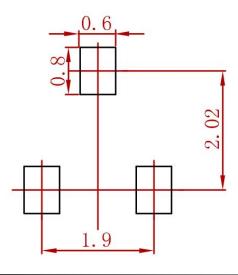






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Syllibol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	) TYP	0.03	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

# **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

## **REEL SPECIFICATION**

P/N	PKG	QTY
2N7002BK-MS	SOT-23	3000



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